SN54LVC74A, SN74LVC74A DUAL POSITIVE-EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH CLEAR AND PRESET

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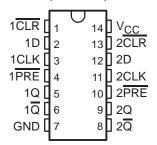
- EPIC[™] (Enhanced-Performance Implanted CMOS) Submicron Process
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Typical V_{OLP} (Output Ground Bounce)
 < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot)
 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Inputs Accept Voltages to 5.5 V
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and DIPs (J)

description

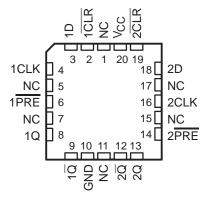
The SN54LVC74A dual positive-edge-triggered D-type flip-flop is designed for 2.7-V to 3.6-V V_{CC} operation and the SN74LVC74A dual positive-edge-triggered D-type flip-flop is designed for 1.65-V to 3.6-V V_{CC} operation.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are

SN54LVC74A . . . J OR W PACKAGE SN74LVC74A . . . D, DB, OR PW PACKAGE (TOP VIEW)



SN54LVC74A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

The SN54LVC74A is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74LVC74A is characterized for operation from –40°C to 85°C.



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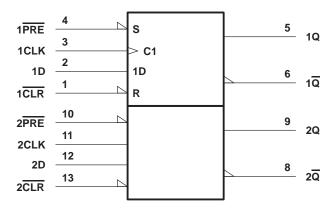
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FUNCTION TABLE

	INP	UTS		OUTI	PUTS
PRE	CLR	CLK	D	Q	Q
L	Н	Х	Χ	Н	L
Н	L	X	Χ	L	Н
L	L	X	Χ	н†	H [†]
Н	Н	\uparrow	Н	Н	L
Н	Н	\uparrow	L	L	Н
Н	Н	L	Χ	Q ₀	\overline{Q}_0

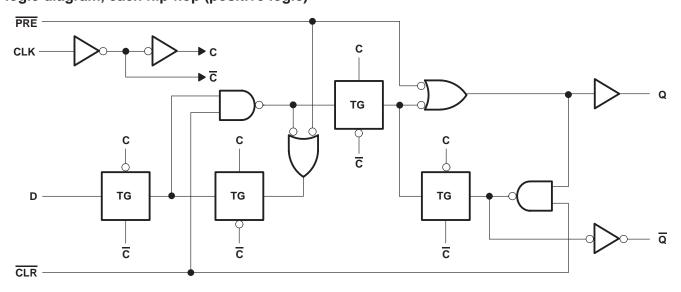
[†]This configuration is unstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.

logic symbol‡



[‡] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, PW, and W packages.

logic diagram, each flip-flop (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply-voltage range, V _{CC}		 –0.5 V to 6.5 V
Input-voltage range, V _I (see Note 1)		 –0.5 V to 6.5 V
Output-voltage range, VO (see Notes 1 and 2)		 \dots –0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)		 –50 mA
Output clamp current, I _{OK} (V _O < 0)		 –50 mA
Continuous output current, IO		 ±50 mA
Continuous current through V _{CC} or GND		 ±100 mA
Package thermal impedance, θ _{JA} (see Note 3)): D package .	 127°C/W
	DB package	 158°C/W
	PW package	 170°C/W
Storage temperature range, T _{stg}		 –65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. The value of V_{CC} is provided in the recommended operating conditions table.
- 3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

			SN54L\	/C74A	SN74L	VC74A	
			MIN	MAX	MIN	MAX	UNIT
\/	Cupphyyoltogo	Operating	2	3.6	1.65	3.6	V
VCC	Supply voltage	Data retention only	1.5		1.5		V
		V _{CC} = 1.65 V to 1.95 V			0.65×V _{CC}		
V_{IH}	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$			1.7		V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		2		
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$				0.35×V _{CC}	
V_{IL}	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$				0.7	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		0.8	
٧ _I	Input voltage		0	5.5	0	5.5	V
٧o	Output voltage		0	Vcc	0	Vcc	V
		V _{CC} = 1.65 V				-4	
lau	High lovel output ourrent	V _{CC} = 2.3 V				-8	mA
ЮН	High-level output current	V _{CC} = 2.7 V		-12		-12	IIIA
		V _{CC} = 3 V		-24		-24	
		V _{CC} = 1.65 V				4	
la.	Low level output ourrent	V _{CC} = 2.3 V				8	m Λ
lOL	Low-level output current	V _{CC} = 2.7 V		12		12	mA
		V _{CC} = 3 V		24		24	
Δt/Δν	Input transition rise or fall rate		0	10	0	10	ns/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPLTIONS		SN	54LVC7	4A	SN	74LVC7	4A	LINUT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP†	MAX	MIN	TYP [†]	MAX	UNIT
	100	1.65 V to 3.6 V				V _{CC} -0.	.2		
	I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} -0	.2					
	I _{OH} = -4 mA	1.65 V				1.2			
Voн	I _{OH} = -8 mA	2.3 V				1.7			V
	12 mA	2.7 V	2.2			2.2			
	I _{OH} = -12 mA	3 V	2.4			2.4			
	I _{OH} = -24 mA	3 V	2.2			2.2			
	100	1.65 V to 3.6 V						0.2	
	I _{OL} = 100 μA	2.7 V to 3.6 V			0.2				
Voi	I _{OL} = 4 mA	1.65 V						0.45	V
VOL	I _{OL} = 8 mA	2.3 V						0.7	V
	I _{OL} = 12 mA	2.7 V			0.4			0.4	
	I _{OL} = 24 mA	3 V			0.55			0.55	
lį	V _I = 5.5 V or GND	3.6 V			±5			±5	μΑ
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V			10			10	μΑ
ΔICC	One input at V _{CC} – 0.6 V, Other inputs at V _{CC} or GND	2.7 V to 3.6 V			500			500	μΑ
C _i	$V_I = V_{CC}$ or GND	3.3 V		5			5		pF

[†] All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

				SN54L	/C74A		
			VCC =	2.7 V	V _{CC} =	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	
fclock	Clock frequency			83		100	MHz
	Pulse duration	PRE or CLR low	3.3		3.3	3.3	
t _W	ruise duration	3.3		3.3		ns	
	Setup time before CLK↑	Data	3.4		3		ns
t _{su}	Setup time before CENT	2.2		2		115	
th	Hold time, data after CLK↑		1		1	·	ns

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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

					SN74L	VC74A					
			V _{CC} =	1.8 V 5 V	V _{CC} =	2.5 V 2 V	V _{CC} =	2.7 V	V _{CC} =	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fclock	Clock frequency			†		†		83		100	MHz
	Pulse duration	PRE or CLR low	†		†		3.3		3.3		
t _W	CLK high or low		†		†		3.3		3.3		ns
	Catum time hafara CLKA	Data	†		†		3.4		3		ns
t _{su}	Setup time before CLK↑	PRE or CLR inactive	†		†		2.2		2		115
th	Hold time, data after CLK↑		†		†		1		0		ns

[†] This information was not available at the time of publication.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER							
	FROM (INPUT)	I		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V	
			MIN	MAX	MIN	MAX	
f _{max}			83		100		MHz
	tnd Q or Q		6	1	5.2		
^t pd	PRE or CLR	QUIQ		6.4	1	5.4	ns

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER						SN74L	VC74A				
	FROM (INPUT)	TO (OUTPUT)	V _{CC} =		V _{CC} =	2.5 V 2 V	V _{CC} =	2.7 V	V _{CC} =	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fmax			†		†		83		100		MHz
t .	CLK	Q or $\overline{\mathbb{Q}}$	†	†	†	†		6	1	5.2	ns
^t pd	PRE or CLR	QorQ	†	†	†	†		6.4	1	5.4	113
t _{sk(o)} ‡										1	ns

 $[\]overline{^{\dagger}}$ This information was not available at the time of publication.

operating characteristics, T_A = 25°C

	PARAMETER	TEST CONDITIONS	V _{CC} = 1.8 V ± 0.15 V	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT
		CONDITIONS	TYP	TYP	TYP	
C _{pd}	Power dissipation capacitance per flip-flop	f = 10 MHz	†	†	27	pF

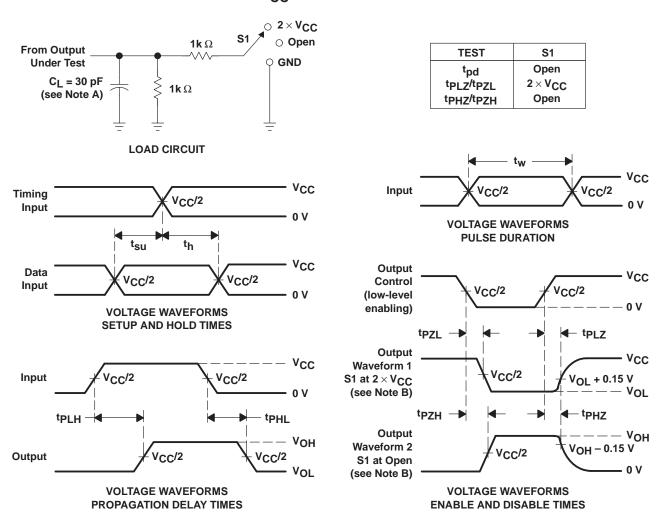
[†] This information was not available at the time of publication.



[‡] Skew between any two outputs of the same package switching in the same direction

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PARAMETER MEASUREMENT INFORMATION $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$



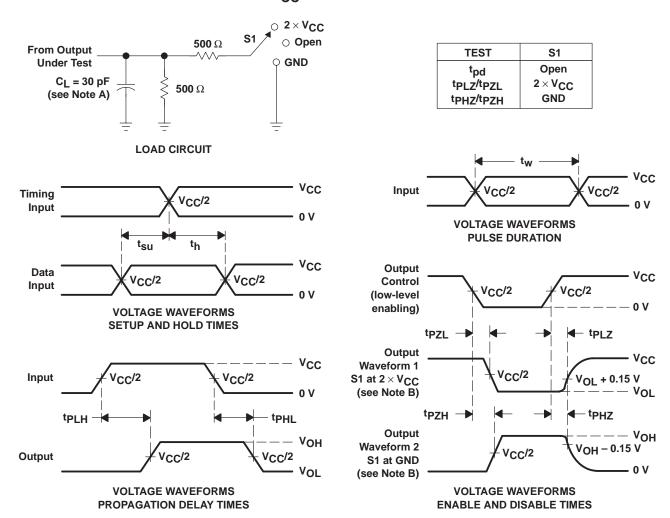
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{Ω} = 50 Ω , $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzl and tpzH are the same as ten.
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$



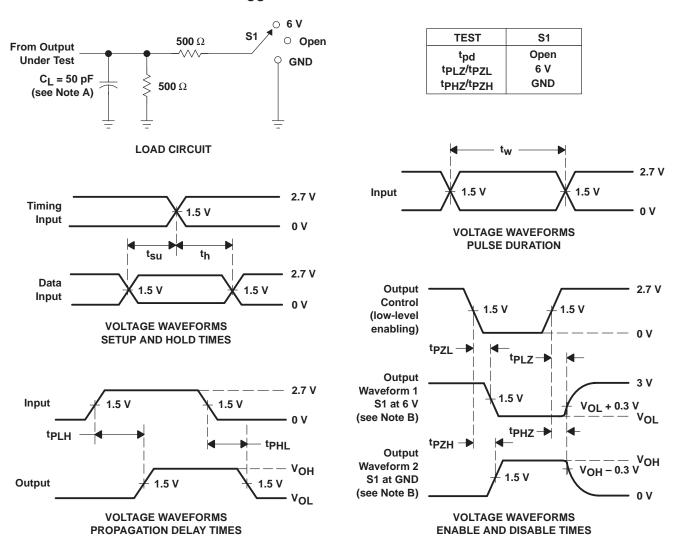
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2 ns. $t_f \leq$ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

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PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.7 V AND 3.3 V \pm 0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_{O} = 50 \Omega$, $t_{f} \leq$ 2.5 ns, $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzi and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms



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